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Application/Control No.	Applicant(s)/Patent under Reexamination	
09/934,299	THESLING ET AL.	
Examiner	Art Unit	
Jacob Meek	2637	

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Class	Subclass	Date	Examiner	
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370	252,343	8/12/2005	JM	
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		DATE	EXMR
East		8/12/2005	JM
NPL		8/12/2005	JM
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